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	Application No.	Applicant(s)	
Notice of Allowability	10/828,322	NAKAMOTO, TAKAHIRO	
Notice of Allowability	Examiner	Art Unit	
	Allan R. Wilson	2815	
The MAILING DATE of this communication appears on the cover sheet with the correspondence address All claims being allowable, PROSECUTION ON THE MERITS IS (OR REMAINS) CLOSED in this application. If not included herewith (or previously mailed), a Notice of Allowance (PTOL-85) or other appropriate communication will be mailed in due course. THIS NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS. This application is subject to withdrawal from issue at the initiative of the Office or upon petition by the applicant. See 37 CFR 1.313 and MPEP 1308.			
1. This communication is responsive to the documents filed on 21 April 2004.			
2. The allowed claim(s) is/are <u>1-4.</u>			
3. The drawings filed on 21 April 2004 are accepted by the Examiner.			
 4. Acknowledgment is made of a claim for foreign priority un a) All b) Some* c) None of the: 1. Certified copies of the priority documents have 2. Certified copies of the priority documents have 3. Copies of the certified copies of the priority documents have International Bureau (PCT Rule 17.2(a)). * Certified copies not received: 	been received. been received in Application No		
Applicant has THREE MONTHS FROM THE "MAILING DATE" of noted below. Failure to timely comply will result in ABANDONM THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.	of this communication to file a reply o ENT of this application.	complying with the requirements	
5. A SUBSTITUTE OATH OR DECLARATION must be submitted. Note the attached EXAMINER'S AMENDMENT or NOTICE OF INFORMAL PATENT APPLICATION (PTO-152) which gives reason(s) why the oath or declaration is deficient.			
6. CORRECTED DRAWINGS (as "replacement sheets") must (a) including changes required by the Notice of Draftsperso 1) hereto or 2) to Paper No./Mail Date (b) including changes required by the attached Examiner's Paper No./Mail Date ldentifying indicia such as the application number (see 37 CFR 1.1 each sheet. Replacement sheet(s) should be labeled as such in the	on's Patent Drawing Review (PTO-S Amendment / Comment or in the O	ffice action of	
7. DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL.			
Attachment(s) 1. ☑ Notice of References Cited (PTO-892) 2. ☐ Notice of Draftperson's Patent Drawing Review (PTO-948)	6. 🔲 Interview Summary (atent Application (PTO-152) (PTO-413),	
 Information Disclosure Statements (PTO-1449 or PTO/SB/08 Paper No./Mail Date <u>21 April 2004</u> 	Paper No./Mail Date 8), 7. Examiner's Amendm	ent/Comment	
4. ☐ Examiner's Comment Regarding Requirement for Deposit	8. X Examiner's Statemer	nt of Reasons for Allowance	
of Biological Material	9.		

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REASONS for ALLOWANCE

The following is an examiner's statement of reasons for allowance:

A close prior art, Hase et al. (U.S. Patent No. 6,365,925), discloses most of the limitations of the claims, but fails to show at least an n-type second compound semiconductor layer having an impurity doping density ranging form $1x10^{17} \text{cm}^{-3}$ to $1x10^{18} \text{cm}^{-3}$ with an energy level lower than the first compound semiconductor layer and energy level greater than the third compound semiconductor layer.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Conclusion

The prior art made of record and not relied upon is considered pertinent to applicant's disclosure: Bayraktaroglu (illustrates a MESFET with InGaAs etch stop), Jeong et al. (illustrates a FET with GaAs and AlGaAs layers), Minetani (illustrates compound semiconductor MESFET) and Passlack et al. (illustrates a EMOFET with III-V semiconductor substrate).

Field of Search	Date
U.S. Class and subclass:	
257/183, 192	May 18, 2005
Other Documentation:	
None	N/A
Electronic data base(s):	
EAST (USPAT, US-PGPUB, JPO, EPO, Derwent, IBM TDB)	May 18, 2005

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Any inquiry concerning this communication or earlier communications from an examiner should be directed to Primary Examiner Allan Wilson whose telephone number is (571) 272-1738. Examiner Wilson can normally be reached 7:00-4:00 Monday-Friday.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Tom Thomas can be reached on (571) 272-1664. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Allan R. Wilson Primary Examiner 18 May 2005